

Gong Zhang^{1, #}, Haibo Wang^{1, #}, Jishen Zhang^{1, #}, Chao Wang¹,
Haiwen Xu¹, Yan Liang², Charles Lim^{1, 3, *}, and Xiao Gong^{1, *}

¹Department of Electrical & Computer Engineering, National University of Singapore, Singapore,

²School of Optical-Electrical and Computer Engineering, University of Shanghai for Science and Technology, China,

³Centre for Quantum Technologies, National University of Singapore, Singapore.

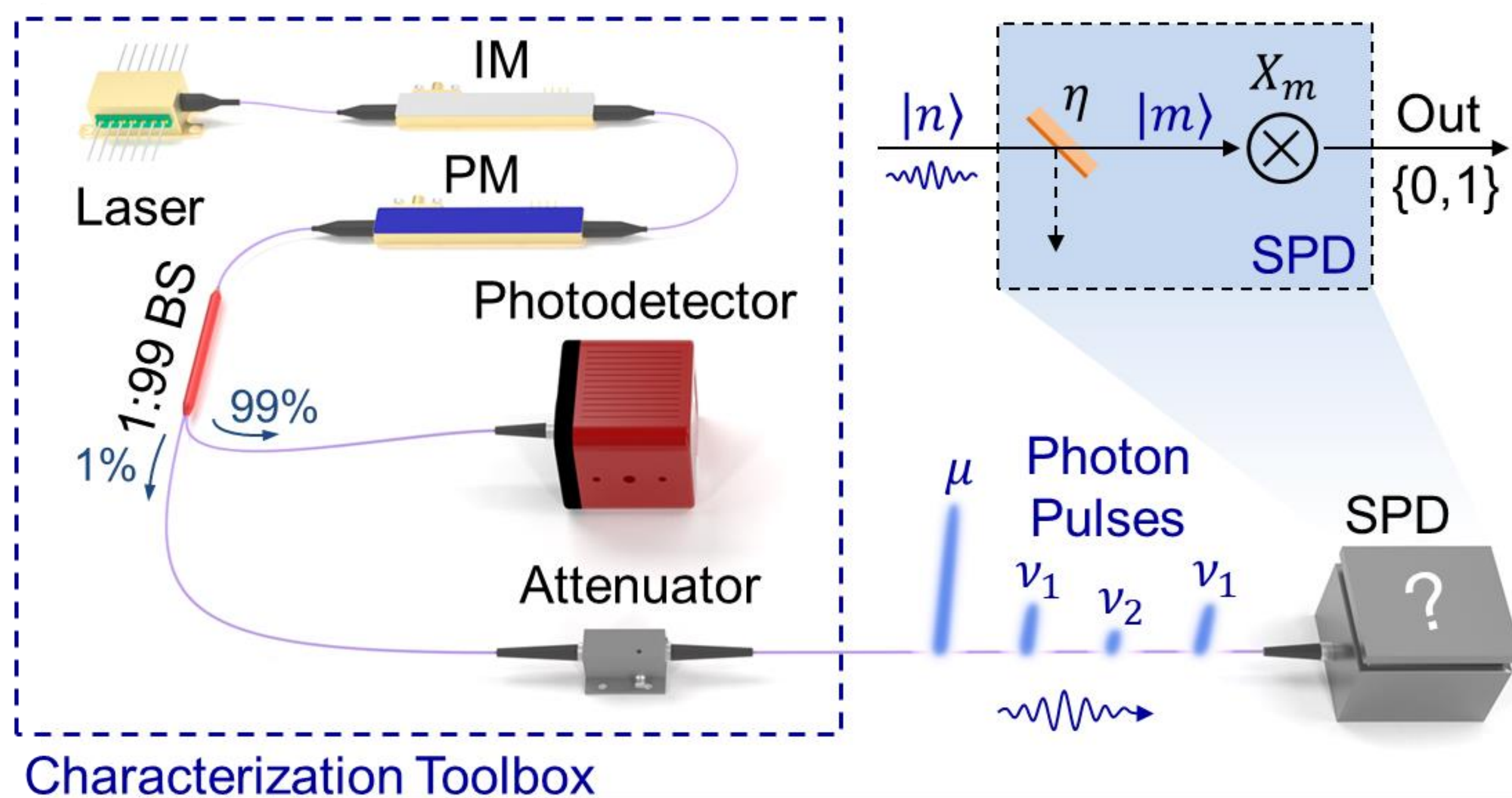
*Corresponding Author: charles.lim@nus.edu.sg; elegong@nus.edu.sg. #These authors contributed equally.

INTRODUCTION AND KEY CONTRIBUTIONS

Conventional single-photon detectors (SPDs) characterization methods require detailed detector models, which are not always available. The decoy-state scheme can provide rigorous bounds on the background noise and single-photon detection efficiency (SPDE) without the need for any prior knowledge of the detector model. This work provides a new and generalized toolbox for rigorous SPDE characterization with relaxed assumptions on the detector model, which could open up new possibilities in device calibration standards and quantum information applications.

- Generalized method without the requirement for detector model
- Provide rigorous bound on SPDE and noise with finite-size analysis
- Precise measurement with weak coherent source
- Multiphoton response, nonlinear response, time-dependency does not affect the result

CHARACTERIZATION SCHEME AND GENERALIZED SPD MODEL



$$Y_n = \Pr(\text{click}|n) = \sum_m \binom{n}{m} (1-\eta)^{n-m} \eta^m X_m$$

$$X_m = \Pr(\text{click}|m)$$

Y_0 is dark count and Y_1 is the SPDE with noise included

Vacuum-insensitive SPD
SPAD, SNSPD, PMT

$X_0 = Y_0 = \text{dark count}$
 $X_1 = 1$
SPDE is defined as η

Vacuum-sensitive SPD
Threshold homodyne detector

$X_0 = \text{noise} + \text{vacuum state}$
 $X_1 = \text{noise} + \text{single photon}$
SPDE is defined as Y_1 [1]

[1] Grice, W. & Walmsley, I., J. Mod. Opt. 43, 795-805 (1996)

DECOY STATE MODEL

Gain: Probability of a detection event given input mean photon number μ [2-5]

$$Q_\mu = \sum_{n=0}^{\infty} Y_n \frac{\mu^n}{n!} e^{-\mu}$$

Considering statistic fluctuation in the experiment, the gain can be bounded using Hoeffding's inequality [6]

$$Q_\mu^\pm = Q_\mu \pm \sqrt{\frac{1}{2l_\mu} \ln\left(\frac{1}{\varepsilon}\right)}$$

The input signal is mixed by three weak coherent states with different mean photon numbers μ , v_1 , and v_2 ($0 \leq v_2 < v_1, v_1 + v_2 < \mu$)

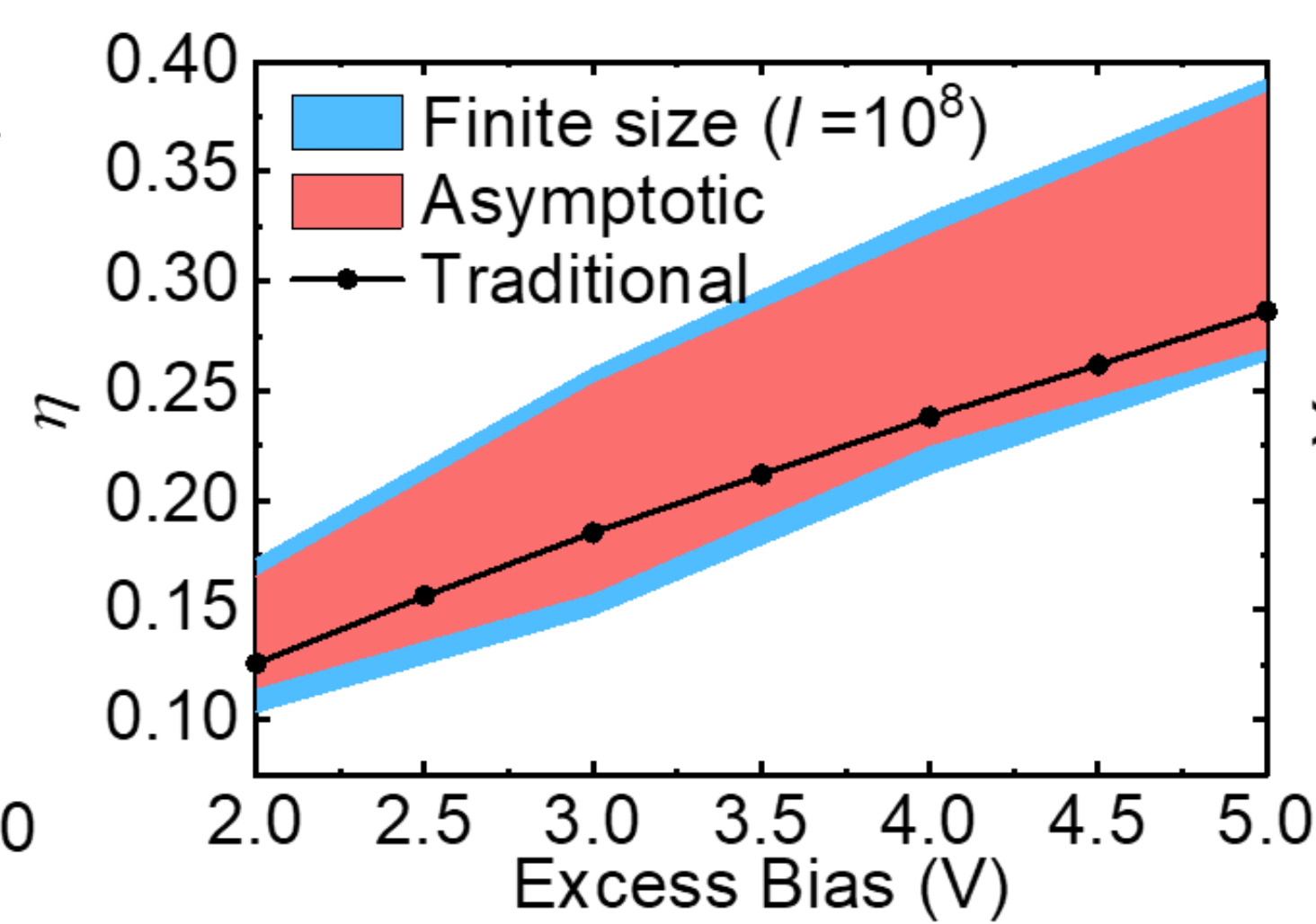
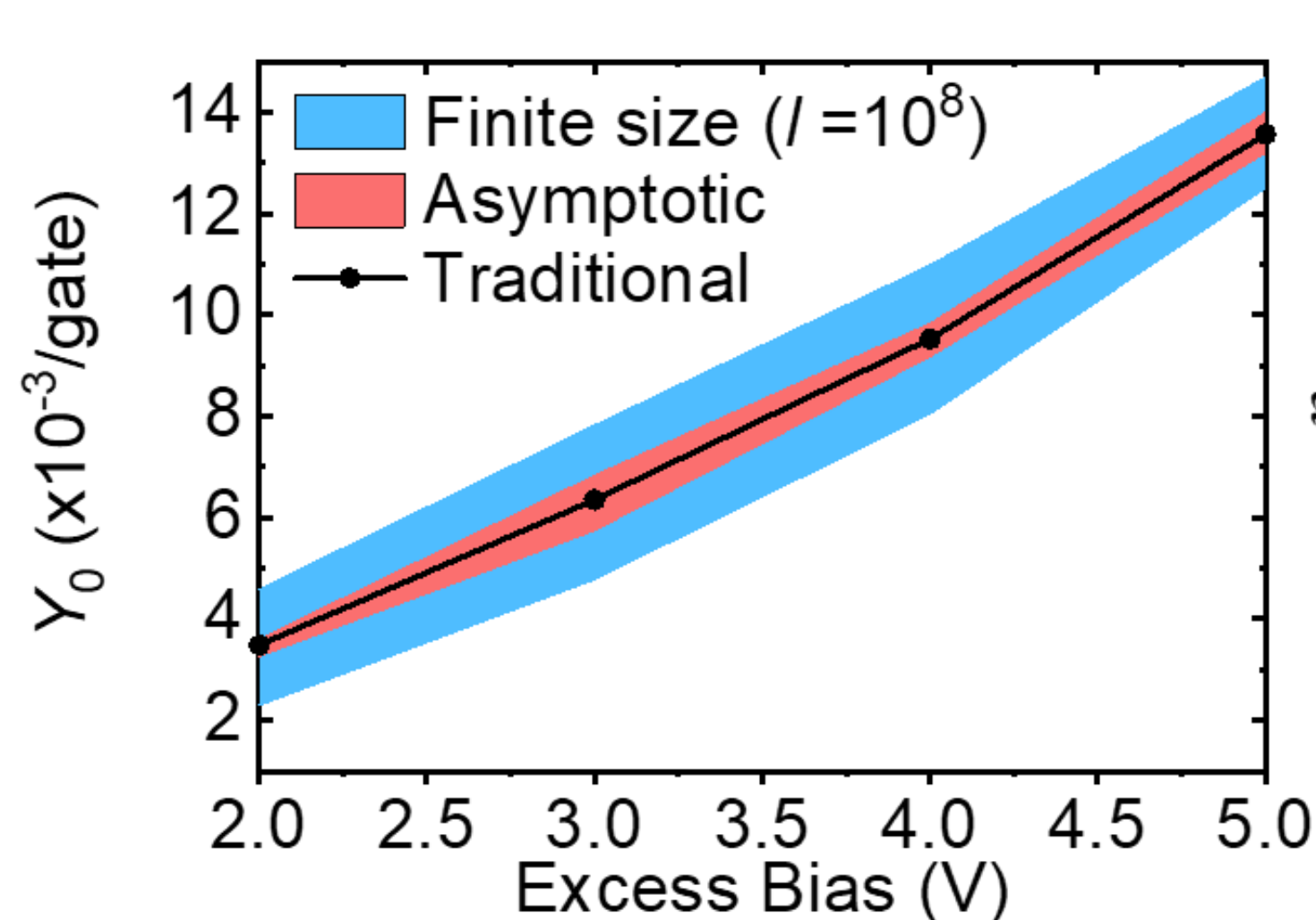
$$Y_0 \geq Y_0^L = \max\left\{\frac{v_1 Q_{v_2}^- e^{v_2} - v_2 Q_{v_1}^+ e^{v_1}}{v_1 - v_2}, 0\right\} \quad Y_1 \leq Y_1^U = \min\left\{\frac{Q_{v_1}^+ e^{v_1} - Q_{v_2}^- e^{v_2}}{v_1 - v_2}, 1\right\}$$

$$Y_1 \geq Y_1^L = \max\left\{\frac{\mu \left(Q_{v_1}^- e^{v_1} - Q_{v_2}^+ e^{v_2} - \frac{v_1^2 - v_2^2}{\mu^2} (Q_\mu^+ e^\mu - Y_0^L) \right)}{\mu v_1 - \mu v_2 - v_1^2 + v_2^2}, 0\right\}$$

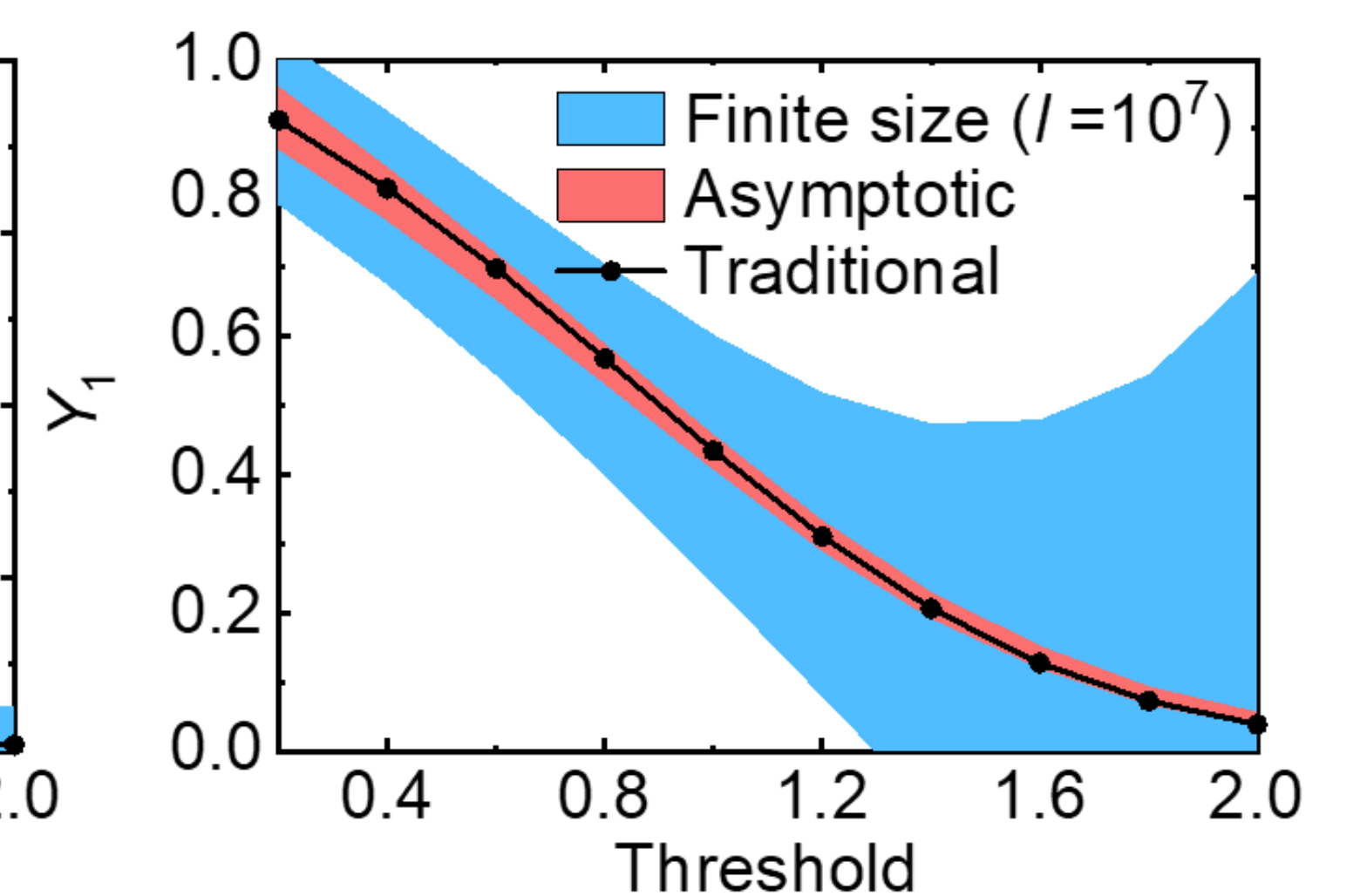
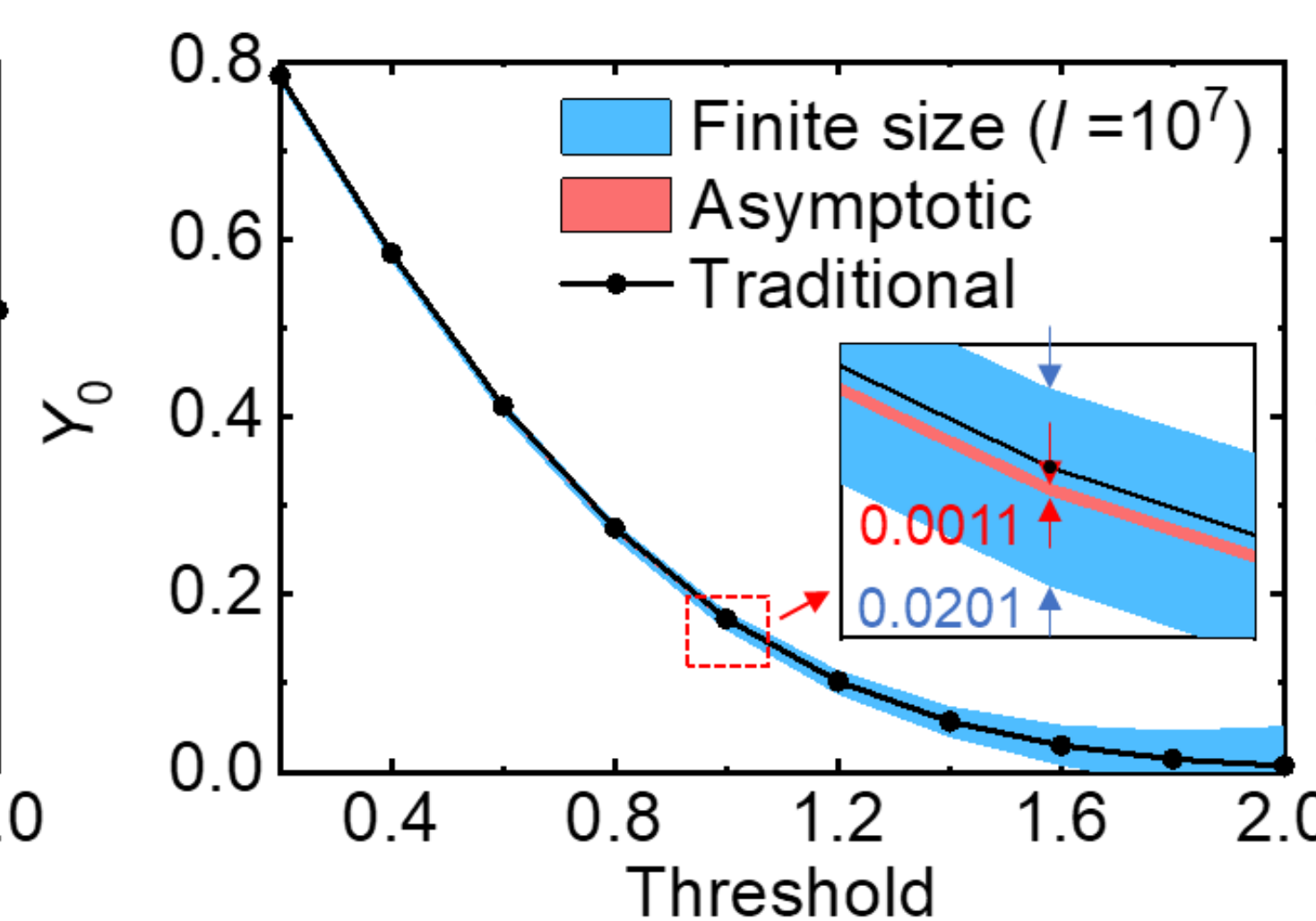
$$Y_0 \leq Y_0^U = \min\left\{\frac{\mu^2 \left(v_1 Q_{v_2}^+ e^{v_2} - v_2 Q_{v_1}^- e^{v_1} + \frac{v_1 v_2 (v_1 - v_2)}{\mu^2} (Q_\mu^+ e^\mu - Y_1^L \mu) \right)}{(v_1 - v_2)(\mu^2 + v_1 v_2)}, 1\right\}$$

[2] Lo, H.-K., Phys. Rev. Lett. 94, 230504 (2005). [3] Ma, X., Phys. Rev. A 72, 012326 (2005). [4] Wang, X.-B., Phys. Rev. Lett. 94, 230503 (2005). [5] Hwang, W.-Y., Phys. Rev. Lett. 91, 057901 (2003). [6] Hoeffding, W., (Springer, 1994).

EXPERIMENTAL RESULTS FOR AN SPAD AND A HOMODYNE DETECTOR



For SPAD, μ , v_1 , $v_2 = 0.960$, 0.214 , 0.007 , sample size 10^8 , protocol error $\varepsilon = 10^{-10}$



For homodyne detector, μ , v_1 , $v_2 = 1.156$, 0.095 , 0.028 , sample size 10^7 , protocol error $\varepsilon = 10^{-10}$

CONCLUSIONS

A generalized method based on the decoy-state scheme is proposed and experimentally demonstrated to accurately characterize single-photon detectors. Rigorous bounds for the background noise and SPDE are provided for both a SPAD and a homodyne detector. The resulting bounds are verified with the traditional methods. It shows great potential to become a standard toolbox for SPD characterization and be used in future quantum information applications.